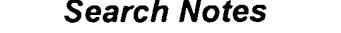


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/003,341	TREIBACH-HECK ET AL.	
	<b>Examiner</b> Asfand M. Sheikh	<b>Art Unit</b> 3627	

## **Search Notes**



**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner